EIS Characterization of Passive Films Formed on AlxCoCrFeNi Alloys UNIVERSIDAD DE LAS PALMAS DE GRAN CANARIA M.López Ríos, 1 N.Florido Suárez 1, I.Voiculescu 2, V.Geanta 2, J.C.Mirza Rosca 1* UNIVERSITATEA ¹ Las Palmas de Gran Canaria University, Mech. Eng. Dept., Spain **POLITEHNICA** ² Politehnica University of Bucharest, LAMET, Bucharest, Romania DIN BUCUREȘTI Electrochemical Impedance Spectroscopy (EIS) CORROSION BEHAVIOUR measurements have been performed on High Entropy Alloys (HEAs) type AlxCoCrFeNi with different aluminium content (x = 0.6; Two equivalent circuits, with one HEA 5 HEA 6 HEA 1 0.8 and 1.0) in order to time constant (passive film) and COMPONENTS characterize their passive AlCrFeCoNi Al_{0.8}CrFeCoNi Al_{0.6}CrFeCoNi two time constants (charge M film and corrosion transfer reactions) respectively, Al, wt% 10,67 8,72 6,68 resistance at 37°C under can be satisfactory used for fitting the spectra. Cr, wt% 20,55 21,00 21,47 simulated physiological conditions (Ringer's Fe, wt% 22,13 22,61 23,12 solution) acidulated with Co, wt% 23,32 23,82 24,36 HClat pH=3Ni, wt% 23,33 23,85 24,36 Impedance S2-4 $Z(f) = \frac{R_2 + R_1 (1 + j 2\pi f C_2 R_2)}{1 + j 2\pi f C_2 R_2 + j 2\pi f C_1 (R_2 + R_1 (1 + j 2\pi f C_2 R_2))}$ Nyquist Diagram (-lm(Z) vs. Re(Z)) The polarization resistance and the double layer capacity were compared at different polarization Nanometric image potentials for the of HEAS surface detection of the after fracture passive film structure (Scanning Electron and the roughness of the electrode surface. Microscope) HEA1 HEA1 **BODE** plot METALLOGRAPHY log(Z) vs frequency vs phase (Z) [-0.7V - E_{corr}] **BODE** plot log(Z) vs frequency vs phase (Z) [E_{corr} - 0.7V] It can be seen for all materials that the resistance of the passive film is very high and decreases slightly with the potential: the very high resistance of the passive film implies a high corrosion resistance which can HEA5 be attributed to the formation of the protective oxide layer. **BODE** plot log(Z) vs frequency vs phase (Z) [-0.7V - E_{corr}] HEA6 R. Kotoka et al. / Journal of Materials Science & Technology 31 (2015) 873-8 **BODE** plot Saline Oxide log(Z) vs frequency vs phase (Z) solution [E_{corr} - 0.7V] Substrate **BODE** plot log(Z) vs frequency vs phase (Z) [-0.7V - E_{corr}] There is a decrease in the values of the impedance of CPE (slope of the lg[Z] vs lg(f) in Bode plots), related to the rugosity of the electrode surface. **BODE** plot log(Z) vs frequency vs phase (Z) [E_{corr} - 0.7V] NanoMedicine International Conference and Exhibition 2019 / 23-25 October / Lisbon, Portugal